

MOSFET – N-Channel, UltraFET Trench

150 V, 27 A, 47 m Ω

FDMS2572

General Description

UltraFET $^{\text{m}}$ devices combine characteristics that enable benchmark efficiency in power conversion applications. Optimized for $r_{DS(on)}$, low ESR, low total and Miller gate charge, these devices are ideal for high frequency DC to DC converters.

Features

- Max $r_{DS(on)} = 47 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 4.5 \text{ A}$
- Max $r_{DS(on)} = 53 \text{ m}\Omega$ at $V_{GS} = 6 \text{ V}$, $I_D = 4.5 \text{ A}$
- Low Miller Charge
- Optimized Efficiency at High Frequencies
- UIS Capability (Single Pulse and Repetitive Pulse)
- This Device is Pb-Free and is RoHS Compliant

Applications

- Distributed Power Architectures and VRMs
- Primary Switch for 24 V and 48 V Systems
- High Voltage Synchronous Rectifier

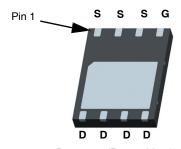
MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
V _{DS}	Drain to Source Voltage	150	V
V _{GS}	Gate to Source Voltage	±20	V
I _D	$\label{eq:continuous} \begin{split} & \text{Drain Current:} \\ & - \text{Continuous (Package limited) } T_{\text{C}} = 25^{\circ}\text{C} \\ & - \text{Continuous (Silicon limited) } T_{\text{C}} = 25^{\circ}\text{C} \\ & - \text{Continuous, } T_{\text{A}} = 25^{\circ}\text{C} \text{(Note 1a)} \\ & - \text{Pulsed} \end{split}$	27 27 4.5 30	A
E _{AS}	Single Pulse Avalanche Energy (Note 3)	150	mJ
P _D	Power Dissipation: $T_C = 25^{\circ}C$ $T_A = 25^{\circ}C$ (Note 1a)	78 2.5	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

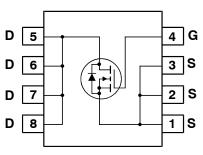
Symbol	ymbol Parameter		Unit
$R_{\theta JC}$	R _{θJC} Thermal Resistance, Junction to Case		°C/W
$R_{\theta JA}$	R _{0,JA} Thermal Resistance, Junction to Ambient (Note 1a)		



Power 56 (Bottom View)

WDFN8 5x6, 1.27P CASE 506DP

ELECTRICAL CONNECTION



N-Channel MOSFET

MARKING DIAGRAM



&Z = Assembly Plant Code

&2 = Numeric Date Code

&K = Lot Code

FDMS2572 = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 3 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARAG	CTERISTICS					u
BVDSS	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	150			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C		180		mV/°C
IDSS	Zero Gate Voltage Drain Current	V _{DS} = 120 V, V _{GS} = 0 V			1	μΑ
Igss	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
ON CHARAC	TERISTICS (Note 2)			•	•	•
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250 \mu A$	2	3	4	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		-9.8		mV/°C
		V _{GS} = 10 V, I _D = 4.5 A		36	47	
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 6 V, I _D = 4.5 A		39	53	mΩ
		V _{GS} = 10 V, I _D = 4.5 A, T _J = 125 °C		69	103	
9FS	Forward Transconductance	V _{DS} = 10 V, I _D = 4.5 A		14		S
DYNAMIC CH	IARACTERISTICS			•	·	III
C _{iss}	Input Capacitance			1960	2610	pF
C _{oss}	Output Capacitance	V _{DS} = 75 V, V _{GS} = 0 V,		130	175	pF
C _{rss}	Reverse Transfer Capacitance	f = 1 MHz		30	45	pF
R _g	Gate Resistance	f = 1 MHz	0.1	1.3	2.6	Ω
SWITCHING (CHARACTERISTICS			!	!	1
t _{d(on)}	Turn-On Delay Time			11	20	ns
t _r	Rise Time	V _{DD} = 75 V, I _D = 1.0 A,		8	16	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$		38	61	ns
t _f	Fall Time			31	50	ns
Q _{g(TOT)}	Total Gate Charge at 10 V	V_{GS} = 0 V to 10 V, V_{DD} = 75 V, I_D = 4.5 A		31	43	nC
Q _{gs}	Gate to Source Gate Charge	.,,		9		nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{DD} = 75 V, I _D = 4.5 A		7		nC
DRAIN-SOUI	RCE DIODE CHARACTERISTICS					
VsD	Source to Drain Diode Forward Voltage	$.V_{GS} = 0 \text{ V}, I_S = 2.2 \text{ A}$ (Note 2)		0.7	1.0	V
t _{rr}	Reverse Recovery Time	I _F = 4.5 A, di/dt = 100 A/μs		67	101	ns
Q _{rr}	Reverse Recovery Charge	1.5 π, αημε = 100 πημο		130	195	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 \times 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 50° C/W when mounted on a 1 in² pad of 2 oz copper.



b) 125°C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3. E_{AS} of 150 mJ is based on starting T_J = 25°C, L = 3 mH, I_{AS} = 10 A, V_{DD} = 150 V. V_{GS} = 10 V.

ORDERING INFORMATION AND PACKAGE MARKING

Device		Device Marking	Package	Shipping [†]	
	FDMS2572	FDMS2572	WDFN8 5x6, 1.27P (Pb-Free)	3000 Units / Tape & Reel	

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

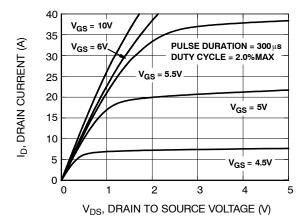


Figure 1. On-Region Characteristics

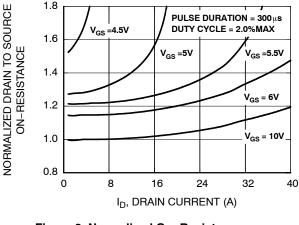


Figure 2. Normalized On–Resistance vs.
Drain Current and Gate Voltage

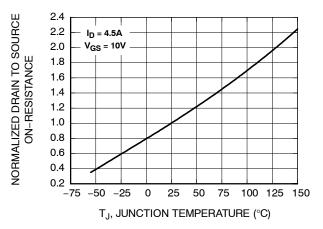


Figure 3. Normalized On–Resistance vs. Junction Temperature

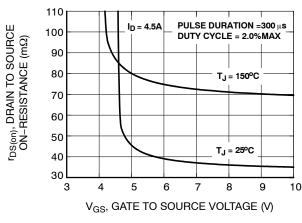


Figure 4. On-Resistance vs. Gate to Source Voltage

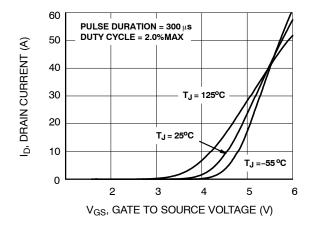


Figure 5. Transfer Characteristics

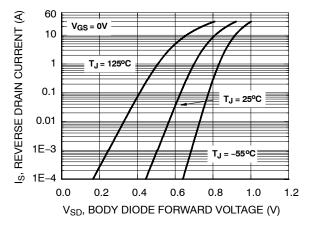


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

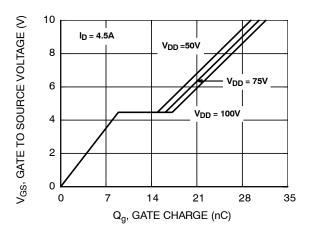


Figure 7. Gate Charge Characteristics

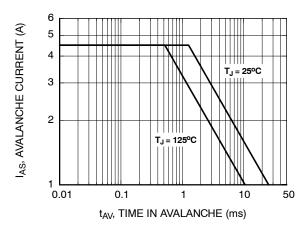


Figure 9. Unclamped Inductive Switching Capability

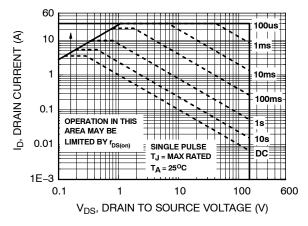


Figure 11. Forward Bias Safe Operating Area

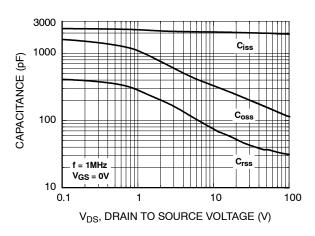


Figure 8. Capacitance vs. Drain to Source Voltage

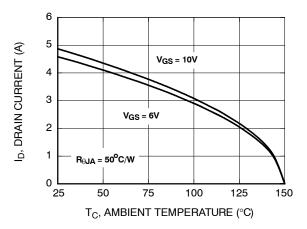


Figure 10. Maximum Continuous Drain Current vs. Ambient Temperature

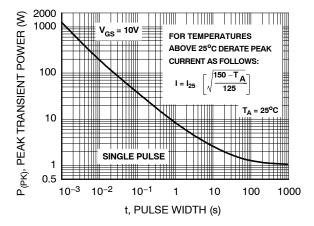


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

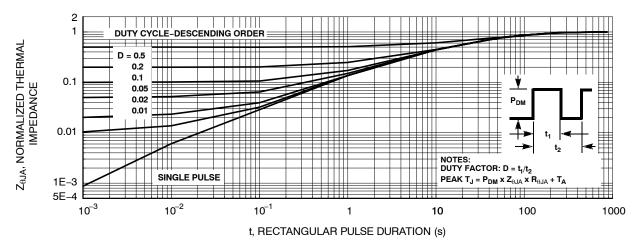


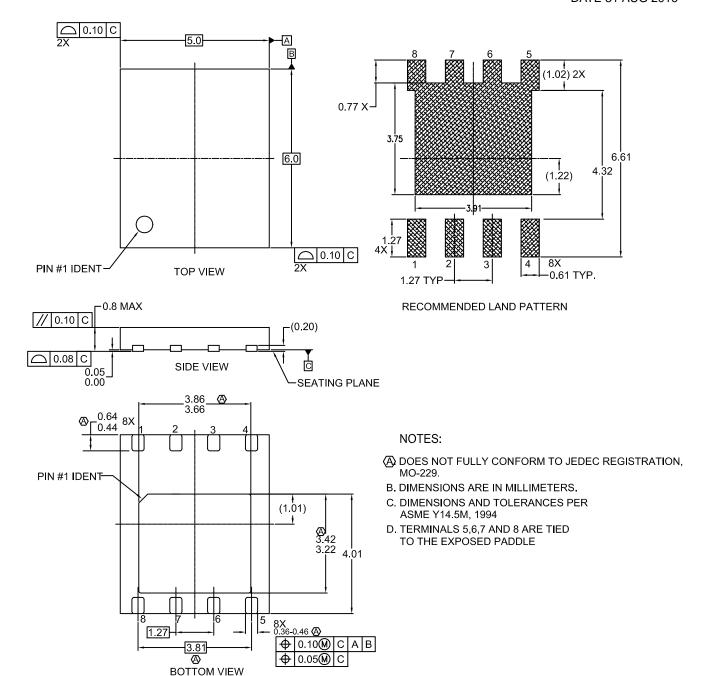
Figure 13. Transient Thermal Response Curve

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